

30V COMPLEMENTARY PAIR ENHANCEMENT MODE MOSFET

Product Summary

Device	V _{(BR)DSS}	R _{DS(on)} max	I _D max T _A = 25°C (Notes 4 & 7)		
01	30V	120mΩ @ V _{GS} = 10V			
Q1	307	180mΩ @ V _{GS} = 4.5V	3.0A		
00	201/	210mΩ @ V _{GS} = -10V	-2.7A		
Q2	-30V	330mΩ @ V _{GS} = -4.5V	-2.2A		

Description and Applications

This MOSFET has been designed to minimize the on-state resistance $(R_{DS(on)})$ and yet maintain superior switching performance, making it ideal for high efficiency power management applications.

- MOSFET gate drive
- LCD backlight inverters
- Motor control
- Portable applications

Features and Benefits

- Low profile package, for thin applications
- Low R_{θJA}, thermally efficient package
- 6mm² footprint, 50% smaller than TSOP6 and SOT23-6
- Low on-resistance
- Fast switching speed
- "Lead-Free", RoHS Compliant (Note 1)
- Halogen and Antimony Free. "Green" Device (Note 2)
- Qualified to AEC-Q101 Standards for High Reliability

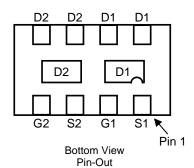
Mechanical Data

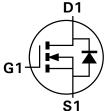
- Case: DFN3020B-8
- Terminals: Pre-Plated NiPdAu leadframe
- Nominal package height: 0.8mm
- UL Flammability Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Solderable per MIL-STD-202, Method 208
- Weight: 0.013 grams (approximate)



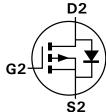
Top View

Bottom View









Q2 P-Channel

Equivalent Circuit

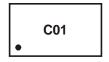
Ordering Information (Note 3)

ĺ	Part Number	Marking	Reel size (inches)	Tape width (mm)	Quantity per reel
	ZXMC3AMCTA	C01	7	8	3000

Notes:

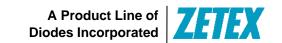
- 1 No purposefully added lead
- 2. Diodes Inc's "Green" policy can be found on our website at http://www.diodes.com.
- 3. For packaging details, go to our website at http://www.diodes.com.

Marking Information



C01 = Product Type Marking Code Top view, Dot Denotes Pin 1





Maximum Ratings @TA = 25°C unless otherwise specified

Characteristic			Symbol	N-channel – Q1	P-channel – Q2	Unit
Drain-Source Voltage			V_{DSS}	30	-30	V
Gate-Source Voltage			V _{GSS}	±20	±20	V
		(Notes 4 & 7)		3.7	-2.7	
Continuous Drain Current	$V_{GS} = 10V$	T _A = 70°C (Notes 4 & 7)	I_{D}	3.0	-2.2	۸
		(Notes 3 & 7)		2.9	-2.1	A
Pulsed Drain Current	$V_{GS} = 10V$	(Notes 6 & 7)	I _{DM}	13	-9.2	
Continuous Source Current (Body diode) (Notes 4 & 7)		Is	3.2	-2.8		
Pulse Source Current (Body diode) (Notes 6 & 7)			I _{SM}	13	-9.2	

Thermal Characteristics @TA = 25°C unless otherwise specified

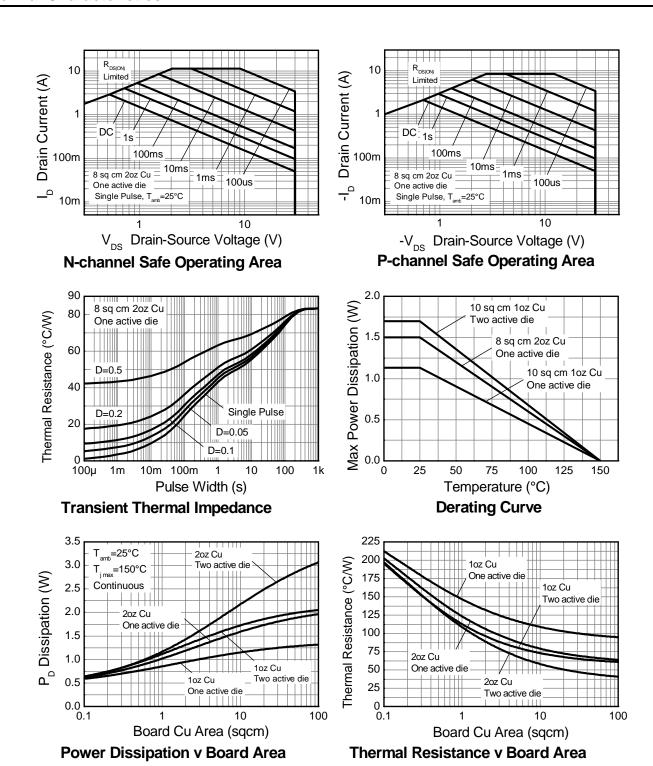
Characteristic		Symbol	N-channel – Q1 P-channel – Q2	Unit	
	(Notes 3 & 7)		1.50 12		
Power Dissipation	(Notes 4 & 7)		2.45 19.6	W	
Linear Derating Factor	(Notes 5 & 7)	- P _D	1.13 9	mW/°C	
	(Notes 5 & 8)		1.70 13.6		
	(Notes 3 & 7)		83.3		
Thermal Desistance Investigate Archiest	(Notes 4 & 7)		51.0		
Thermal Resistance, Junction to Ambient	(Notes 5 & 7)	R _{0JA}	111	°C/W	
	(Notes 5 & 8)		73.5		
Thermal Resistance, Junction to Lead (Notes 7 & 9)		$R_{ heta JL}$	17.1		
Operating and Storage Temperature Range	T _J , T _{STG}	-55 to +150	°C		

Notes:

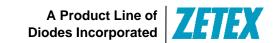
- 3. For a device surface mounted on 28mm x 28mm (8cm²) FR4 PCB with high coverage of single sided 2oz copper, in still air conditions; the device is measured when operating in a steady-state condition. The heatsink is split in half with the exposed drain pads connected to each half.
- 4. Same as note (3) except the device is measured at t < 5 sec.
- 5. Same as note (3), except the device is surface mounted on 31mm x 31mm (10cm²) FR4 PCB with high coverage of single sided 1oz copper.
- 6. Same as note (3), except the device is pulsed with D = 0.02 and pulse width 300µs. The pulse current is limited by the maximum junction temperature.
- 7. For a dual device with one active die.
- 8. For dual device with 2 active die running at equal power.
- 9. Thermal resistance from junction to solder-point (at the end of the drain lead).



Thermal Characteristics







Electrical Characteristics – Q1 N-Channel @TA = 25°C unless otherwise specified

Characteristic	Symbol	Min	Тур	Max	Unit	Test C	Condition
OFF CHARACTERISTICS							
Drain-Source Breakdown Voltage	BV _{DSS}	30	-	-	V	$I_D = 250 \mu A, V_{GS} = 0 V$	
Zero Gate Voltage Drain Current	I _{DSS}	-	-	0.5	μА	V _{DS} = 30V, V _{GS} = 0V	
Gate-Source Leakage	I _{GSS}	-	-	±100	nA	$V_{GS} = \pm 20V$, $V_{DS} = 0V$	
ON CHARACTERISTICS							
Gate Threshold Voltage	V _{GS(th)}	1.0	-	3.0	V	$I_D = 250 \mu A, V_D$	s = V _{GS}
Static Drain-Source On-Resistance (Note 10)			0.100	0.120	Ω	$V_{GS} = 10V, I_D =$	= 2.5A
Static Drain-Source On-Resistance (Note 10)	R _{DS (ON)}	-	0.140	0.180	12	$V_{GS} = 4.5V, I_D$	= 2.0A
Forward Transconductance (Note 10 & 11)	g _{fs}	-	3.5	-	S	$V_{DS} = 10V, I_{D} =$	= 2.5A
Diode Forward Voltage (Note 10)	V _{SD}	-	0.85	0.95	V	$I_S = 1.7A, V_{GS}$	= 0V
Reverse Recover Time (Note 11)	t _{rr}	-	17.7	-	ns	I _S = 2.5A, di/dt= 100A/µs	
Reverse Recover Charge (Note 11)	Q _{rr}	-	13.0	-	nC	$I_S = 2.5A$, $I_S = 2.5A$	= 100A/μS
DYNAMIC CHARACTERISTICS (Note 11)							
Input Capacitance	C _{iss}	-	190	-	pF	V 05V V 0V	
Output Capacitance	Coss	-	38	-	pF	$V_{DS} = 25V, V_{GS}$ f = 1.0MHz	s = 0V,
Reverse Transfer Capacitance	C _{rss}	-	20	-	pF	1 = 1.01/11/12	
Total Gate Charge (Note 12)	Qg	-	2.3	-	nC	$V_{GS} = 4.5V$	
Total Gate Charge (Note 12)	Qq	-	3.9	-	nC		$V_{DS} = 15V$
Gate-Source Charge (Note 12)	Q _{gs}	-	0.6	-	nC	V _{GS} = 10V	$I_D = 2.5A$
Gate-Drain Charge (Note 12)	Q _{gd}	-	0.9	-	nC	7	
Turn-On Delay Time (Note 12)	t _{D(on)}	-	1.7	-	ns		
Turn-On Rise Time (Note 12)	t _r	-	2.3	-	ns	V _{DS} = 15V, I _D =	= 2.5A
Turn-Off Delay Time (Note 12)	t _{D(off)}	-	6.6	-	ns	$V_{GS} = 10V, R_G = 6\Omega$	
Turn-Off Fall Time (Note 12)	, , ,						

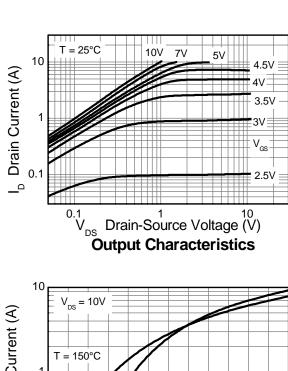
Notes:

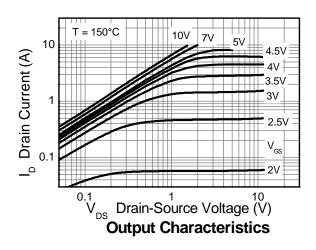
- 10. Measured under pulsed conditions. Width \leq 300 μ s. Duty cycle \leq 2%.
- 11. For design aid only, not subject to production testing.

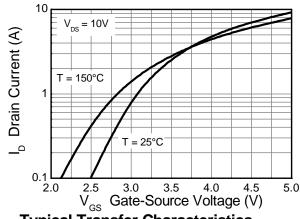
 12. Switching characteristics are independent of operating junction temperature.

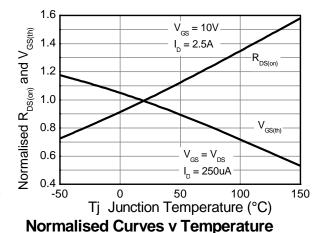


Typical Electrical Characteristics – Q1 N-Channel

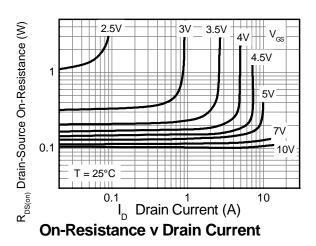


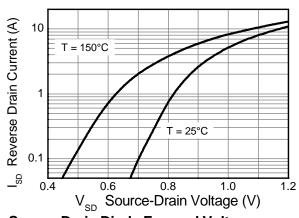






Typical Transfer Characteristics

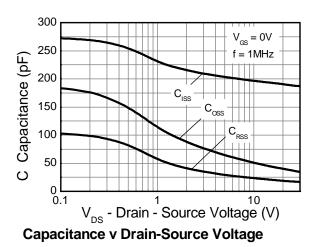


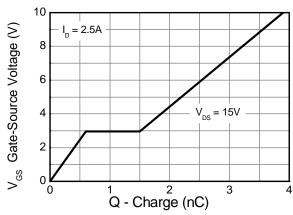


Source-Drain Diode Forward Voltage



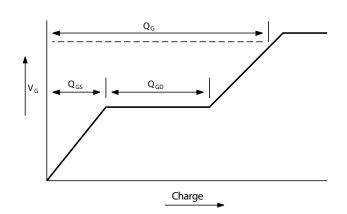
Typical Electrical Characteristics - Q1 N-Channel - Continued





Gate-Source Voltage v Gate Charge

Test Circuits



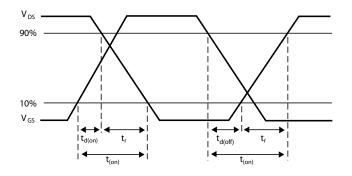
Current regulator

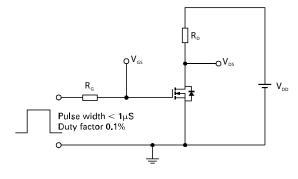
12V 0.2μF 50k D.U.T

V_{os}

Basic gate charge waveform

Gate charge test circuit

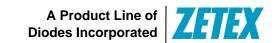




Switching time waveforms

Switching time test circuit





Electrical Characteristics – Q2 P-Channel @TA = 25°C unless otherwise specified

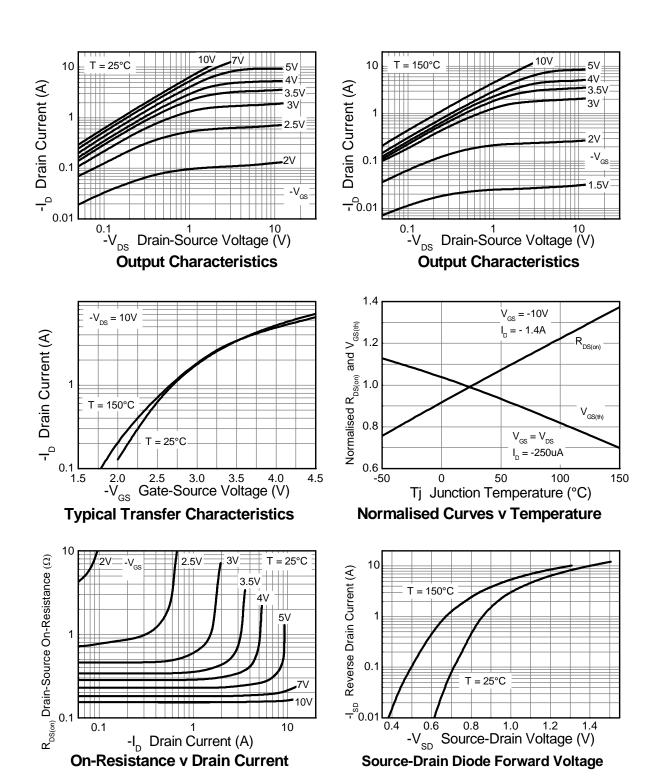
Characteristic	Symbol	Min	Тур	Max	Unit	Test C	Condition
OFF CHARACTERISTICS							
Drain-Source Breakdown Voltage	BV _{DSS}	-30	-	-	V	$I_D = -250 \mu A, V_{GS} = 0 V$	
Zero Gate Voltage Drain Current	I _{DSS}	-	-	-0.5	μΑ	V _{DS} = -30V, V _{GS} = 0V	
Gate-Source Leakage	I _{GSS}	-	-	±100	nA	$V_{GS} = \pm 20V, V_{DS} = 0V$	
ON CHARACTERISTICS							
Gate Threshold Voltage	V _{GS(th)}	-1.0	-	-3.0	V	$I_D = -250 \mu A, V_1$	$DS = V_{GS}$
Static Drain-Source On-Resistance (Note 13)	Ь		0.150	0.210	Ω	$V_{GS} = -10V, I_D$	= -1.4A
Static Drain-Source Off-Resistance (Note 13)	R _{DS (ON)}	-	0.280	0.330	12	$V_{GS} = -4.5V, I_{D}$	e -1.1A
Forward Transconductance (Note 13 & 14)	g fs	-	2.48	-	S	V _{DS} = -15V, I _D = -1.4A	
Diode Forward Voltage (Note 13)	V_{SD}	-	-0.85	-0.95	V	$I_S = -1.1A, V_{GS}$; = 0V
Reverse Recover Time (Note 14)	t _{rr}	-	18.6	-	ns	I _S = -0.95A, di/dt = 100A/µs	
Reverse Recover Charge (Note 14)	Q _{rr}	-	14.8	-	nC IS = -0.95A, di		αι = 100A/μS
DYNAMIC CHARACTERISTICS (Note 14)							
Input Capacitance	C _{iss}	-	206	-	pF	V _{DS} = -15V, V _{GS} = 0V, f = 1.0MHz	
Output Capacitance	Coss	-	59.3	-	pF		
Reverse Transfer Capacitance	C _{rss}	-	49.2	-	pF	1 = 1.01/11/12	
Total Gate Charge (Note 15)	Q_{g}	-	3.8	-	nC	$V_{GS} = -4.5V$	
Total Gate Charge (Note 15)	Qq	-	6.4	-	nC		$V_{DS} = -15V$
Gate-Source Charge (Note 15)	Q_{gs}	-	0.69	-	nC	$V_{GS} = -10V$	$I_D = -1.4A$
Gate-Drain Charge (Note 15)	Q _{qd}	-	2.0	-	nC	7	
Turn-On Delay Time (Note 15)	t _{D(on)}	-	1.5	-	ns		
Turn-On Rise Time (Note 15)	t _r	-	2.8	-	ns	$V_{DS} = -15V, I_{D}$	= -1A
Turn-Off Delay Time (Note 15)	t _{D(off)}	-	11.3	-	- ns $V_{GS} = -10V$, $R_G = 6\Omega$		3 = 6Ω
Turn-Off Fall Time (Note 15)		7.5	-	ns			

Notes:

- 13. Measured under pulsed conditions. Width \leq 300 μ s. Duty cycle \leq 2%.
- 14. For design aid only, not subject to production testing.15. Switching characteristics are independent of operating junction temperature.

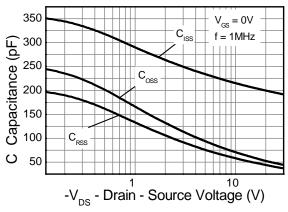


Typical Electrical Characteristics - Q2 P-Channel





Typical Electrical Characteristics - Q2 P-Channel - Continued



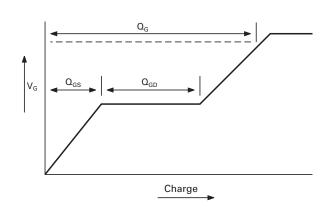
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Capacitance v Drain-Source Voltage

Gate-Source Voltage v Gate Charge

Test Circuits



Current regulator

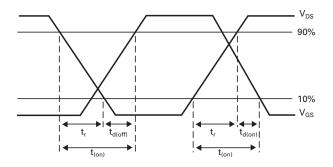
12V 0.2µF 50k Same as D.U.T

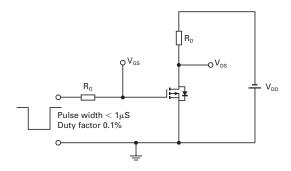
V_{GS}

D.U.T

Basic gate charge waveform

Gate charge test circuit

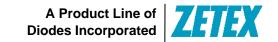




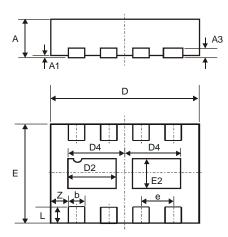
Switching time waveforms

Switching time test circuit



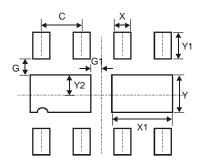


Package Outline Dimensions



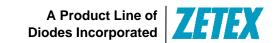
DFN3020B-8						
Dim	Min	Max	Тур			
Α	0.77	0.83	0.80			
A1	0	0.05	0.02			
A3	-	-	0.15			
b	0.25	0.35	0.30			
D	2.95	3.075	3.00			
D2	0.82	1.02	0.92			
D4	1.01	1.21	1.11			
е	-	-	0.65			
Е	1.95	2.075	2.00			
E2	0.43	0.63	0.53			
L	0.25	0.35	0.30			
Z	-	-	0.375			
All Dimensions in mm						

Suggested Pad Layout



Dimensions	Value (in mm)
С	0.650
G	0.285
G1	0.090
X	0.400
X1	1.120
Y	0.730
Y1	0.500
Y2	0.365





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